

|                                   |                                       |   |             |
|-----------------------------------|---------------------------------------|---|-------------|
| <b>Notice of References Cited</b> | Application/Control No.<br>10/736,343 | Applicant(s)/Patent Under<br>Reexamination<br>BERA, RAJENDRA K. |             |
|                                   | Examiner<br>Ryan P. Fiegler           | Art Unit<br>2183  | Page 1 of 2 |

**U.S. PATENT DOCUMENTS**

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Name            | Classification |
|---|---|--|-----------------|-----------------|----------------|
| * | A | US-5,842,022                                     | 11-1998         | Nakahira et al. | 717/160        |
|   | B | US-  |                 |                 |                |
|   | C | US-  |                 |                 |                |
|   | D | US-  |                 |                 |                |
|   | E | US-  |                 |                 |                |
|   | F | US-  |                 |                 |                |
|   | G | US-  |                 |                 |                |
|   | H | US-  |                 |                 |                |
|   | I | US-  |                 |                 |                |
|   | J | US-  |                 |                 |                |
|   | K | US-  |                 |                 |                |
|   | L | US-  |                 |                 |                |
|   | M | US-  |                 |                 |                |

**FOREIGN PATENT DOCUMENTS**

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
|   | N |  |                 |         |      |                |
|   | O |  |                 |         |      |                |
|   | P |  |                 |         |      |                |
|   | Q |  |                 |         |      |                |
|   | R |  |                 |         |      |                |
|   | S |  |                 |         |      |                |
|   | T |  |                 |         |      |                |

**NON-PATENT DOCUMENTS**

| * |   | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)   |
|---|---|---|
|   | U | Huang, Tsung-Chuan and Po-Hsueh Hsu. "A Practical run-time technique for exploiting loop-level parallelism." Journal of Systems and Software, 54, 2000. pg 259-271. |
|   | V | Huang, Tsung-Chuan and Cheng-Ming Yang. "Non-linear array data dependence test." Journal of Systems and Software, 57. Elsevier: 2001. pg 145-154                    |
|   | W | Hwang, J.J. et al. "A New Access Control Method Using Prime Factorisation." The Computer Journal, col. 35, No. 1, 1992. pg 16-20.                                   |
|   | X | Tanenbaum, Andrew S. Structured Computer Organization. Second Ed. Prentice: 1984. pg 11-12. 510   |

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

|                                   |                                       |   |             |
|-----------------------------------|---------------------------------------|---|-------------|
| <b>Notice of References Cited</b> | Application/Control No.<br>10/736,343 | Applicant(s)/Patent Under<br>Reexamination<br>BERA, RAJENDRA K. |             |
|                                   | Examiner<br>Ryan P. Fiegler           | Art Unit<br>2183  | Page 2 of 2 |

**U.S. PATENT DOCUMENTS**

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Name | Classification |
|---|---|--|-----------------|------|----------------|
|   | A | US-  |                 |      |                |
|   | B | US-  |                 |      |                |
|   | C | US-  |                 |      |                |
|   | D | US-  |                 |      |                |
|   | E | US-  |                 |      |                |
|   | F | US-  |                 |      |                |
|   | G | US-  |                 |      |                |
|   | H | US-  |                 |      |                |
|   | I | US-  |                 |      |                |
|   | J | US-  |                 |      |                |
|   | K | US-  |                 |      |                |
|   | L | US-  |                 |      |                |
|   | M | US-  |                 |      |                |

**FOREIGN PATENT DOCUMENTS**

| * |   | Document Number<br>Country Code-Number-Kind Code | Date<br>MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
|   | N |  |                 |         |      |                |
|   | O |  |                 |         |      |                |
|   | P |  |                 |         |      |                |
|   | Q |  |                 |         |      |                |
|   | R |  |                 |         |      |                |
|   | S |  |                 |         |      |                |
|   | T |  |                 |         |      |                |

**NON-PATENT DOCUMENTS**

| * |   | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)   |
|---|---|---|
|   | U | Blume, William and Rudolf Eigenmann. "The Range Test: A Dependence Test for Symbolic, Non-linear Expressions." IEEE: 1994. 528-527. 537 |
|   | V | Koblitz, Neal. Algebraic Aspects of Cryptography. Springer: 1999. pg 28.  |
|   | W |   |
|   | X |   |

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.